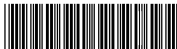


**Search Notes****Application/Control No.**

10/767,250

**Examiner**

AFSAR M. QURESHI

**Applicant(s)/Patent under Reexamination**

TIEDEMANN ET AL.

**Art Unit**

2416

**SEARCHED**

Class	Subclass	Date	Examiner
370	335-338 342, 209	7/1/2009	AQ
375	130-150	7/1/2009	AQ
455	442	7/1/2009	AQ

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
370	209,335	7/1/2009	AQ
455	442	7/1/2009	AQ
375	150	7/1/2009	AQ
Interference search conducted 3/24/2009		7/1/2009	AQ

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Upgraded search: EAST,Class/Text, EPO,JPO,IEEE, USPAT,OCR,PgPub	7/1/2009	AQ
IDS (6/25/2009) and OCR	7/1/2009	AQ
Interference search NOT included (Previously submitted on 3/24/2009)	7/1/2009	AQ